

<b>Notice of References Cited</b>	Application/Control No. 10/575,437	Applicant(s)/Patent Under Reexamination BURDINSKI ET AL.	
	Examiner DAVID H. BANH	Art Unit 4193	Page 1 of 1

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*	B	US-2002/0132398 A1	09-2002	Deane et al.	438/151
*	C	US-6,517,995 B1	02-2003	Jacobson et al.	430/320
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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